Search Notes			

Application/Control No.	Applicant(s)/Patent u Reexamination	nder
10/667,727	SCHEELE ET AL.	
Examiner	Art Unit	
Patrick T. Lewis	1623	

SEARCHED			
Class	Subclass	Date	Examiner
514	54, 58, 841, 931, 934	1/31/2006	PL
536	102, 103	1/31/2006	PL
536	123.1	1/31/2006	PL
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				

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DATE	EXMR
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